

Measurement of the absolute branching fraction of inclusive semielectronic D_s^+ decays

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We measure the inclusive semielectronic decay branching fraction of the D_s^+ meson. A double-tag technique is applied to e^+e^- annihilation data collected by the BESIII experiment at the BEPCII collider, operating in the center-of-mass energy range 4.178–4.230 GeV. We select positrons from $D_s^+ \rightarrow Xe^+\nu_e$

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with momenta greater than 200 MeV/ c and determine the laboratory momentum spectrum, accounting for the effects of detector efficiency and resolution. The total positron yield and semielectronic branching fraction are determined by extrapolating this spectrum below the momentum cutoff. We measure the D_s^+ semielectronic branching fraction to be $(6.30 \pm 0.13(\text{stat.}) \pm 0.09(\text{syst.}) \pm 0.04(\text{ext.}))\%$, showing no evidence for unobserved exclusive semielectronic modes. We combine this result with external data taken from literature to determine the ratio of the D_s^+ and D^0 semielectronic widths, $\frac{\Gamma(D_s^+ \rightarrow X e^+ \nu_e)}{\Gamma(D^0 \rightarrow X e^+ \nu_e)} = 0.790 \pm 0.016(\text{stat.}) \pm 0.011(\text{syst.}) \pm 0.016(\text{ext.})$. Our results are consistent with and more precise than previous measurements.

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I. INTRODUCTION

The D_s^+ meson is the ground state of charmed-strange mesons, and precise measurements of its semileptonic decays allow for crucial tests of Standard Model predictions of flavor-changing interactions. This article presents a new measurement of the D_s^+ -meson inclusive semielectronic branching fraction and positron momentum spectrum. (Here and throughout this article, charge conjugate modes are implied.) A previous measurement by the CLEO-c experiment reported the first results for these quantities, including the measurement of $\mathcal{B}(D_s^+ \rightarrow X e^+ \nu_e) = (6.52 \pm 0.39(\text{stat.}) \pm 0.15(\text{syst.}))\%$ [1]. Measuring this branching fraction with improved precision contributes to a comprehensive understanding of D_s^+ decays and is an important component of the overall experimental and theoretical heavy-flavor physics program.

Table I lists the six exclusive D_s^+ semielectronic modes that have been observed to date and their branching fractions, as well as the branching fraction of $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ and the previously measured $D_s^+ \rightarrow X e^+ \nu_e$ branching fraction [1–15]. By comparing the inclusive semielectronic branching fraction with the sum of all measured exclusive semielectronic branching fractions, we can estimate the branching fraction for further unobserved D_s^+ semielectronic decays. Measurements of the semielectronic branching fractions for different charmed mesons can be combined to probe for nonspectator effects in heavy-meson decays [16,17]. The CLEO-c measurement of the ratio of the D_s^+ and D^0 semielectronic widths, $\frac{\Gamma(D_s^+ \rightarrow X e^+ \nu_e)}{\Gamma(D^0 \rightarrow X e^+ \nu_e)} = 0.815 \pm 0.052$, is in agreement with predictions employing an effective quark model [18] and shows that nonspectator effects are present in semielectronic charmed-meson decays. It has also been demonstrated with CLEO-c data that the inclusive semielectronic momentum spectrum can be used to make sensitive tests for specific nonspectator processes, such as weak annihilation [19,20]. Precise understanding of these processes is required for application of heavy-quark expansion in extracting Cabibbo–Kobayashi–Maskawa (CKM) matrix elements from inclusive semileptonic B meson decays [21]. Thus, the improved precision of both the inclusive branching fraction and the momentum spectrum of D_s^+

semielectronic decays reported in this article have the potential to contribute to reducing theoretical uncertainties in determining CKM parameters with heavy-meson decays.

The remainder of the article is organized in seven sections. The BESIII detector, the analyzed data, and the Monte Carlo (MC) simulation samples are described in Sec. II. An overview of the measurement technique is presented in Sec. III. Event selection requirements based on full reconstruction of hadronic D_s^- decays are discussed in Sec. IV. Semielectronic decay selection requirements and further analysis of candidate signal events are presented in Sec. V. The systematic uncertainties of our measurement are evaluated in Sec. VI. We conclude with a summary of our results in Sec. VII.

II. DETECTOR AND DATA SAMPLES

The BESIII detector records the results of symmetric e^+e^- collisions provided by the BEPCII collider [22]. BEPCII produces collisions at center-of-mass energies (E_{cm}) between 2 and 4.9 GeV, and BESIII has collected the world's largest data samples near a number of pair-production threshold energies for charmed hadrons. The BESIII detector is composed of the following subsystems for particle detection and identification: a helium-based multilayer drift chamber (MDC), a plastic scintillator time-of-flight system (TOF), a CsI(Tl) electromagnetic calorimeter (EMC), a 1.0 T superconducting solenoid, and a set of resistive plate chambers for muon identification. The acceptance of the BESIII detector for charged particles is 93% of the full solid angle. Ionization energy deposits in the MDC are used to reconstruct charged particle tracks and determine particle momenta from the curvature in the magnetic field. The MDC provides a momentum resolution of 0.5% for particles with a momentum of 1 GeV/ c . The end cap TOF system was upgraded in 2015 with multigap resistive plate chamber technology, providing a time resolution of 60 picoseconds [23]. Measurements of charged particle specific ionization in the MDC (dE/dx), the flight time in the TOF, and the energy deposit in the EMC associated with a track are combined to identify particles. A detailed description of the BESIII detector is given in Ref. [24].

Inclusive MC samples with the equivalent of five times the luminosity of data and exclusive MC samples with the

TABLE I. Branching fractions for observed D_s^+ semielectronic decays and for $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$. The listed uncertainties are the total uncertainties. The $D_s^+ \rightarrow f_0(980) e^+ \nu_e$, $f_0(980) \rightarrow \pi\pi$ branching fraction is calculated based on the measurements of $D_s^+ \rightarrow \pi^+ \pi^- e^+ \nu_e$ from [2] and corrected for the corresponding $\pi^0 \pi^0$ branching fraction by an isospin correction factor of $\frac{3}{2}$.

Mode	Averaged branching fraction	
$D_s^+ \rightarrow \phi e^+ \nu_e$	$(2.37 \pm 0.11)\%$	[3–6]
$D_s^+ \rightarrow \eta e^+ \nu_e$	$(2.32 \pm 0.08)\%$	[6–8]
$D_s^+ \rightarrow \eta' e^+ \nu_e$	$(0.80 \pm 0.07)\%$	[6–8]
$D_s^+ \rightarrow K^0 e^+ \nu_e$	$(0.34 \pm 0.04)\%$	[6,9]
$D_s^+ \rightarrow K^*(892)^0 e^+ \nu_e$	$(0.21 \pm 0.03)\%$	[6,9]
$D_s^+ \rightarrow f_0(980) e^+ \nu_e, f_0(980) \rightarrow \pi\pi$	$(0.30 \pm 0.05)\%$	[2]
Sum of semielectronic modes	$(6.34 \pm 0.17)\%$	
$\mathcal{B}(D_s^+ \rightarrow X e^+ \nu_e)$	$(6.52 \pm 0.42)\%$	[1]
$D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \bar{\nu}_\tau \nu_e \nu_\tau$	$(0.96 \pm 0.04)\%$	[10–15]

equivalent of 35 times the luminosity of data are used to optimize selection criteria, investigate distributions of signal and background processes, and determine the efficiencies of our selection criteria. Hadronic simulation samples are produced using the event generators KKMC [25] and EvtGen [26,27]. BabayaganLO [28] is used to produce radiative Bhabha ($e^+ e^- \rightarrow \gamma e^+ e^-$) samples. Final-state radiation (FSR) of particles is simulated with PHOTOS [29]. Interaction of the simulated particles with the detector material is handled by GEANT4 [30], which uses a detailed XML-based description of the detector geometry [31].

In 2016, BESIII collected 3.19 fb^{-1} of data at $E_{\text{cm}} = 4.178 \text{ GeV}$, which provides approximately 6.4×10^6 D_s^+ mesons primarily through the process $e^+ e^- \rightarrow D_s^+ D_s^-$, with a small contribution from $e^+ e^- \rightarrow D_s^+ D_s^-$. We analyze the entirety of this sample, as well as 2.08 fb^{-1} of data collected in 2017 in the E_{cm} range 4.189–4.219 GeV in 2017 and 1.05 fb^{-1} of data collected in the E_{cm} range 4.225–4.230 GeV in 2013. These three samples are analyzed separately due to differing detector and running conditions. A summary of the datasets with their E_{cm} [32], integrated luminosities [33], and estimated number of D_s^+ mesons produced is shown in Table II.

TABLE II. E_{cm} , integrated luminosities, and estimated number of D_s mesons (N_{D_s}) for the analyzed data samples. In each case, the first listed uncertainty is statistical, and the second is systematic.

E_{cm} (MeV)	$\int \mathcal{L} dt$ (pb^{-1})	$N_{D_s} (\times 10^6)$
4178	$3189.0 \pm 0.9 \pm 31.9$	6.4
4189	$526.7 \pm 0.1 \pm 2.2$	1.0
4199	$526.0 \pm 0.1 \pm 2.1$	1.0
4209	$517.1 \pm 0.1 \pm 1.8$	0.9
4219	$514.6 \pm 0.1 \pm 1.8$	0.8
4225–4230 [32]	$1047.3 \pm 0.1 \pm 10.2$ [33]	1.3

III. MEASUREMENT TECHNIQUE

Our analysis procedure employs the double-tag technique pioneered by the MARKIII Collaboration [34]. We fully reconstruct hadronic D_s^- mesons (the tag or tag side) and determine the number of signal events by analyzing the remaining charged tracks unused in the reconstruction of the tags (the recoil or recoil side). We refer to events where a tag meson is found as single-tag events and events where a semielectronic decay is identified on the recoil side in addition to the tag meson as double-tag events. Our single-tag selection is described in more detail in Sec. IV.

Since identification and reconstruction of positron tracks is only possible above a certain momentum threshold with the BESIII detector, double-tag candidate tracks are only accepted with $p > 200 \text{ MeV}/c$. The differential inclusive semielectronic branching fraction as a function of the electron momentum p_e is given as

$$\frac{d\mathcal{B}_{\text{SL}}}{dp_e} = \frac{\Delta(\frac{n_{\text{DT}}}{\epsilon_{\text{DT}}})/\Delta p_e}{n_{\text{ST}}/\epsilon_{\text{ST}}} = \frac{(\frac{\Delta n_{\text{DT}}}{\epsilon_{\text{sig}}})/\Delta p_e}{n_{\text{ST}} \frac{\epsilon'_{\text{ST}}}{\epsilon_{\text{ST}}}} = \frac{\Delta N_{\text{DT}}/\Delta p_e}{n_{\text{ST}} b_{\text{tag}}}. \quad (1)$$

In this equation, n_{ST} is the number of the observed single-tag events, Δn_{DT} is the number of the observed (semielectronic) double-tag events in a particular p_e bin, and ϵ_{ST} and ϵ_{DT} are the single-tag and double-tag reconstruction efficiencies, respectively. We define $\epsilon_{\text{DT}} = \epsilon'_{\text{ST}} \times \epsilon_{\text{sig}}$, where ϵ_{sig} is the momentum-dependent efficiency of reconstructing only the signal side and ϵ'_{ST} is the tag-side reconstruction efficiency given that a signal event is present on the recoil side. We define $b_{\text{tag}} \equiv \frac{\epsilon'_{\text{ST}}}{\epsilon_{\text{ST}}}$ as the tag bias, which accounts for the difference in the single-tag detection efficiency given that a semielectronic decay is present on the recoil side and ΔN_{DT} as the true number of double-tag signal events in our single-tag sample for a particular p_e bin.

We begin our signal selection by sorting recoil-side tracks with $p > 200 \text{ MeV}/c$ into momentum bins. For a given momentum bin, we further sort these tracks by their charge: tracks with charge opposite to the tag [right sign (RS)] and tracks with the same charge as the tag [wrong sign (WS)]. The WS sample is used to estimate charge-symmetric backgrounds in the RS distributions, which include the true signal. For both charge categories in each momentum bin, we sort tracks into three mutually exclusive particle identification hypotheses: electron/positron (e ID), pion (π ID), and kaon (K ID). The similar detector response to muons and pions allows us to treat muons as identical to pions with negligible uncertainty. For each of these six categories in a given momentum bin, we determine the number of tracks that originate from a true D_s^+ meson by fitting to the invariant-mass distribution of the tag D_s^- candidate.

We relate the true number of double-tag signal events in our single-tag sample and the observed number of

signal-candidate tracks from double-tag events through detector response matrices for charged particle tracking (A_{trk}) and particle identification (PID) (A_{PID}):

$$n_{\text{DT}}^b(p_i) = \sum_a A_{\text{PID}}(b|a, p_i) \sum_j A_{\text{trk}}(a|p_i, p_j) N_{\text{DT}}^a(p_j). \quad (2)$$

Here, $A_{\text{trk}}(a|p_i, p_j)$ gives the probability of a particle of type a ($a \in \{e, \pi, K\}$) tracked in momentum bin p_i to have true momentum in bin p_j . Similarly, $A_{\text{PID}}(b|a, p_i)$ gives the probability of a particle of type a passing the PID requirements of particle type b ($b \in \{e, \pi, K\}$) in track momentum bin p_i .

We determine the observed double-tag yields $n_{\text{DT}}^b(p_i)$ by fitting the invariant-mass distribution of tag-side mesons. For both RS and WS tracks in each momentum bin, we account for e ID efficiencies and particles misidentified as positrons with the PID unfolding method introduced in Eq. (2):

$$\begin{bmatrix} n_{\text{trk}}^e \\ n_{\text{trk}}^\pi \\ n_{\text{trk}}^K \end{bmatrix} = A_{\text{PID}}^{-1} \begin{bmatrix} n_{\text{DT}}^e \\ n_{\text{DT}}^\pi \\ n_{\text{DT}}^K \end{bmatrix}, \quad (3)$$

$$A_{\text{PID}} = \begin{bmatrix} \epsilon_e & P_{\pi \rightarrow e} & P_{K \rightarrow e} \\ P_{e \rightarrow \pi} & \epsilon_\pi & P_{K \rightarrow \pi} \\ P_{e \rightarrow K} & P_{\pi \rightarrow K} & \epsilon_K \end{bmatrix}.$$

Here, ϵ_a is the efficiency of our PID selection requirements for the particles of species a , and $P_{a \rightarrow b}$ is the probability of a particle of species a passing the selection requirements for a particle of species b . We apply this PID unfolding to the fitted RS and WS yields for each momentum bin and take the e solution to determine the number of tracked positrons originating from a D_s^+ meson. We then take the difference of the number of tracked RS positrons and WS electrons to subtract the contributions of positrons from Dalitz decays of light mesons in the final state of D_s^+ decay such as $\pi^0 \rightarrow \gamma e^+ e^-$ and any other charge-symmetric backgrounds.

This leaves us with the momentum spectrum of tracked positrons from $D_s^+ \rightarrow X e^+ \nu_e$ events and a smaller contribution from $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$. To account for tracking inefficiency and mismeasurement, we execute the second unfolding from Eq. (2):

$$N_{\text{DT}}(p_j) = A_{\text{trk}}^{-1} n_{\text{trk}}^e(p_j). \quad (4)$$

This provides the true sum of $D_s^+ \rightarrow X e^+ \nu_e$ and $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ positron momentum spectra. We then subtract the contribution of $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ based on the branching fraction in Table I to obtain the $D_s^+ \rightarrow X e^+ \nu_e$ momentum spectrum for $p_e > 200$ MeV/ c . This procedure was validated with five data-sized MC samples and found to recover the correct yields.

To account for positrons with $p_e \leq 200$ MeV/ c , we fit the expected $D_s^+ \rightarrow X e^+ \nu_e$ momentum spectrum with an assumed spectrum, described in more detail in Sec. V, and add the fitted yields in the region $p_e \leq 200$ MeV/ c to the measured yields with $p_e > 200$ MeV/ c . This gives us the signal-efficiency-corrected number of signal events

$$N_{\text{DT}} = N_{p_e > 200 \text{ MeV}/c} + N_{p_e \leq 200 \text{ MeV}/c}, \quad (5)$$

which allows us to calculate the branching fraction similarly to Eq. (1) through

$$\mathcal{B}(D_s^+ \rightarrow X e^+ \nu_e) = \frac{N_{\text{DT}}}{n_{\text{ST}} b_{\text{tag}}}, \quad (6)$$

with the MC simulation prediction of b_{tag} and the determined number of single-tag events n_{ST} .

IV. SINGLE-TAG EVENT SELECTION

We select single-tag candidates using only the $D_s^- \rightarrow K^+ K^- \pi^-$ hadronic decay mode because it is unique in having sufficient statistics and well-known backgrounds. All tag candidate decay products are required to satisfy the following track-quality requirements: the track must originate from a region within 1 (10) cm of the $e^+ e^-$ interaction point perpendicular (parallel) to the z axis, which is the symmetry axis of the MDC, and must be tracked with an angle θ with respect to the z axis that satisfies $|\cos \theta| < 0.93$. We apply π/K ID based on dE/dx and TOF measurements to all tag-candidate daughters to maximize the purity of the tag sample. Multiple candidates in a single event are allowed, both to increase the single-tag selection efficiency and to minimize the tag bias, b_{tag} . We calculate the recoil mass against the tag D_s^- candidate,

$$M_{\text{Rec}} c^2 = [(E_{\text{cm}} - \sqrt{|\vec{p}_{D_s^-} c|^2 + m_{D_s^-}^2 c^4})^2 - |\vec{p}_{D_s^-} c|^2]^{\frac{1}{2}}, \quad (7)$$

where $\vec{p}_{D_s^-}$ is the momentum of the reconstructed tag D_s^- candidate and $m_{D_s^-}$ is the known D_s mass [35]. We require the recoil mass to be consistent with a $D_s^{*+} D_s^-$ event hypothesis by imposing requirements for each dataset: $2057 < M_{\text{Rec}} < 2177$ MeV/ c^2 for $E_{\text{cm}} = 4.178$ GeV, $2145 < M_{\text{Rec}} < 2190$ MeV/ c^2 for $E_{\text{cm}} = 4.189$ – 4.219 GeV, and $2150 < M_{\text{Rec}} < 2200$ MeV/ c^2 for $E_{\text{cm}} = 4.225$ – 4.230 GeV. For about 20% of cases, our event selection identifies more than one candidate per event after these recoil-mass requirements. Background due to extra candidates is subtracted as part of the fitting procedure described later in this section. The M_{Rec} distributions for each dataset can be seen in Fig. 1. While differences between the MC simulation and data can be seen in the figure, our measurement is not sensitive to the MC simulation of this distribution.

We determine the number of true single-tag candidates by performing an unbinned fit to the distribution of the

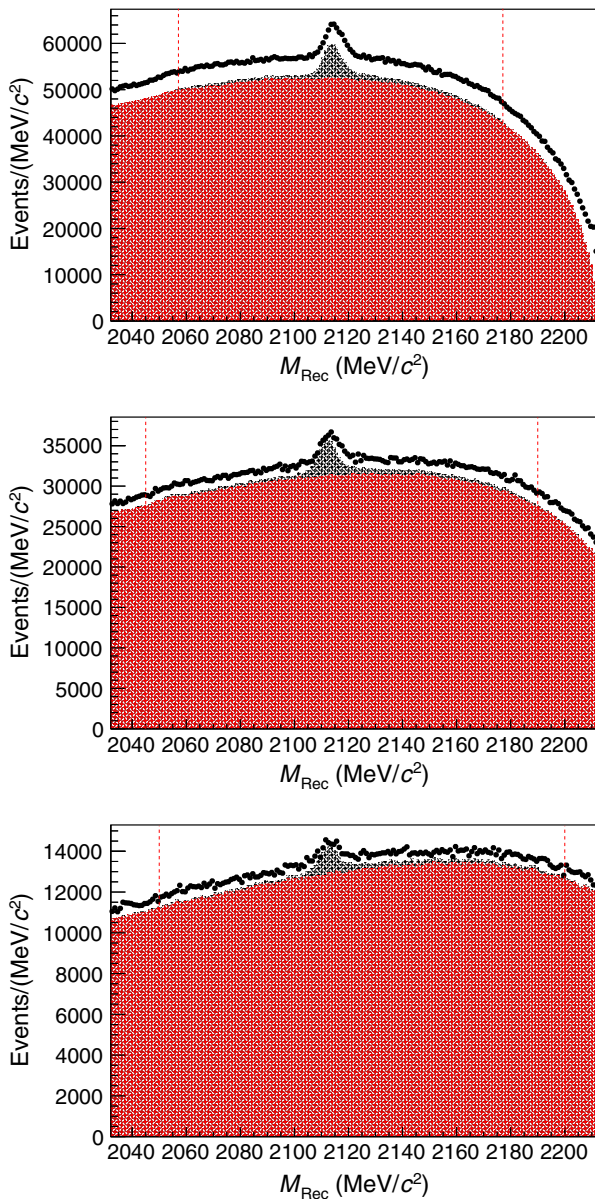


FIG. 1. Recoil-mass distribution of $D_s^- \rightarrow K^+ K^- \pi^-$ candidates from the $E_{\text{cm}} = 4.178$ GeV (upper), $E_{\text{cm}} = 4.189\text{--}4.219$ GeV (middle), and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV (lower) datasets. The black points with error bars are data, and the black and red histograms are the signal and background distributions predicted by the MC simulation, scaled by integrated luminosity. The dashed red lines indicate the selection conditions.

invariant mass of the tag D_s^- candidates, M_{Inv} . The signal shape is based on MC simulation and convolved with a Gaussian function whose width and mean are left free in the fit to account for a possible difference in resolution and calibration between data and the MC simulation. The distribution of backgrounds in this variable is modeled using a second-order Chebyshev polynomial. The fit range is chosen to be within ± 40 MeV/c^2 of the known D_s^+ mass for the $E_{\text{cm}} = 4.178$ GeV distribution corresponding to approximately 5σ of the simulated M_{Inv} distribution. In the

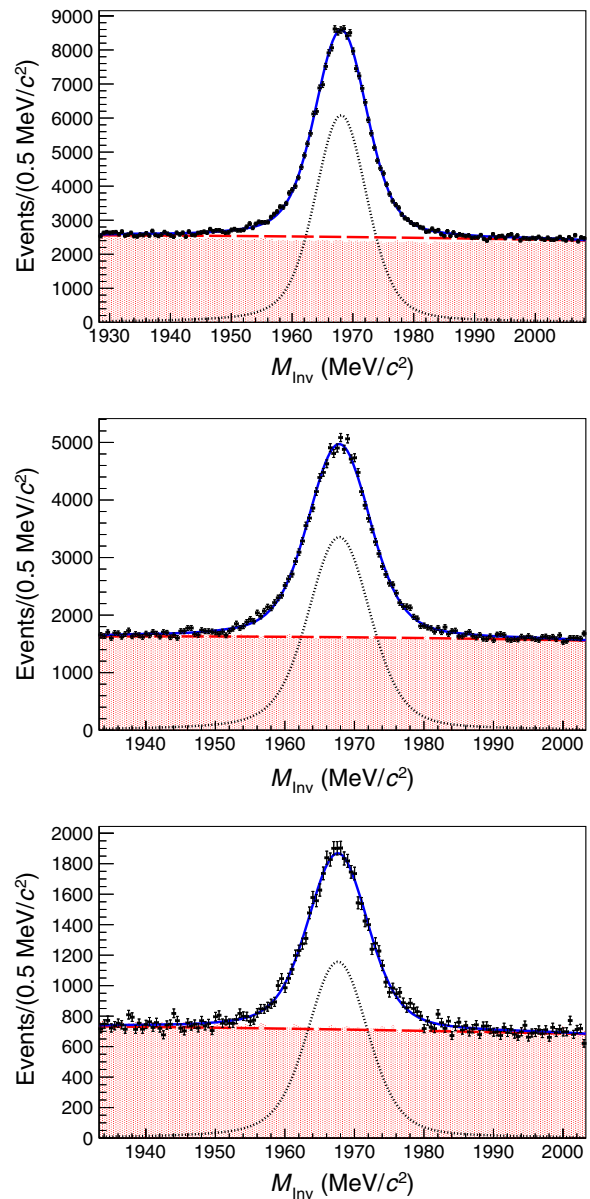


FIG. 2. Results of fits to invariant-mass distributions of $D_s^- \rightarrow K^+ K^- \pi^-$ single-tag candidates from the $E_{\text{cm}} = 4.178$ GeV (upper), $E_{\text{cm}} = 4.189\text{--}4.219$ GeV (middle), and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV (lower) datasets. In each plot, the solid blue line is the result of the total fit, the dashed red line is the fitted distribution of non- $D_s^- \rightarrow K^+ K^- \pi^-$ backgrounds, the dotted black line is the fitted signal distribution, the filled red histogram is the contribution from backgrounds predicted by MC simulation, and the black points with error bars are data. The choice of binning is arbitrary and used solely for display. MC simulation distributions are scaled by luminosity.

$E_{\text{cm}} = 4.189\text{--}4.219$ GeV and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV datasets, the fit range is reduced to be within ± 35 MeV/c^2 of the known D_s mass due to nonpolynomial background structures appearing at the edges of the fit range. The single-tag fits to each dataset are shown in Fig. 2, and the fitted yields are listed in Table III.

TABLE III. Fitted single-tag yields from each dataset. Only statistical uncertainties are shown.

Dataset	Fitted single-tag yields
$E_{\text{cm}} = 4.178$ GeV	147581 ± 779
$E_{\text{cm}} = 4.189\text{--}4.219$ GeV	85845 ± 705
$E_{\text{cm}} = 4.225\text{--}4.230$ GeV	29234 ± 435
Sum	262660 ± 1137

The $E_{\text{cm}} = 4.178$ GeV dataset provides approximately 56% of our single-tag sample, and the $E_{\text{cm}} = 4.189\text{--}4.219$ GeV and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV datasets provide 33% and 11%, respectively. Within each dataset, 99% of our D_s^- candidates comes from $D_s^* D_s$ events, and 1% comes from $D_s D_s$ events. $D_s^* D_s$ events can be produced at $E_{\text{cm}} = 4.225\text{--}4.230$ GeV, but contribute negligibly to our candidate sample.

The single-tag reconstruction efficiency depends on the topology of the recoil-side decay, which we account for through b_{tag} . We determine the tag bias from MC samples for double-tag events from each of the observed semielectronic modes listed in Table I and for $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$. The $D_s^+ \rightarrow X e^+ \nu_e$ tag bias is determined by averaging the tag biases for the six observed modes weighted by the branching fractions in Table I. The single-tag efficiencies with no specification on the signal-side and the determined tag biases for $D_s^+ \rightarrow X e^+ \nu_e$ and $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ for each dataset are shown in Table IV.

V. DOUBLE-TAG SELECTION AND ANALYSIS

After a single-tag candidate is found, we begin searching for positron candidates among the recoil-side tracks. We sort recoil-side tracks that satisfy track requirements defined in Sec. IV into 18 50-MeV/ c momentum bins between 200 MeV/ c and 1100 MeV/ c . Mutually exclusive PID hypotheses are assigned to each track based on information from the MDC, TOF, and EMC.

Based on our PID assignment, we fill tag-side invariant-mass distributions in each momentum bin for each of the six categories of recoil-side tracks defined in Sec. III. We determine the number of tracks in each category originating from true D_s^+ events by performing an unbinned fit to the tag-side invariant-mass distribution with the same signal shape used for the single-tag fit, with the Gaussian

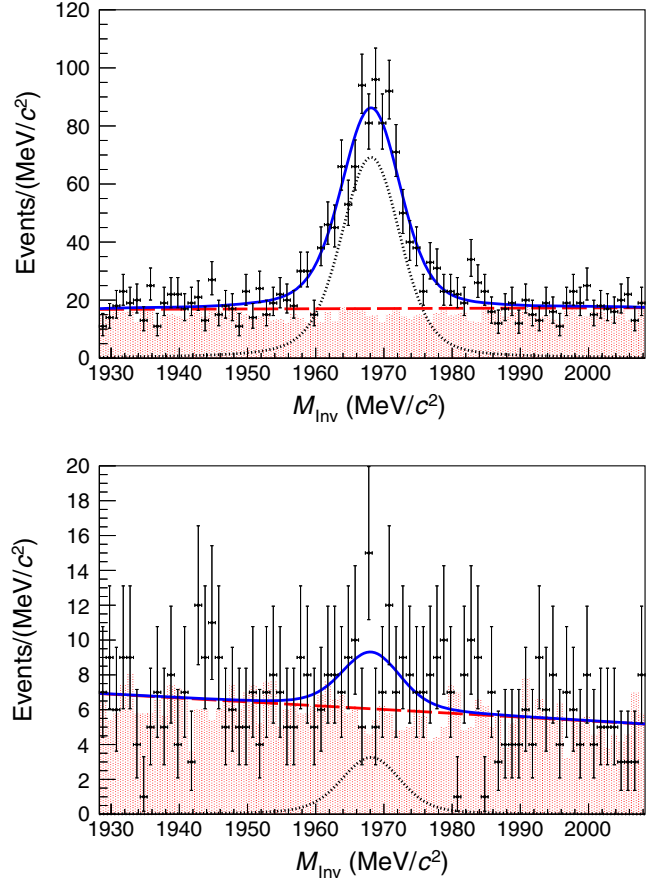


FIG. 3. Example tag invariant-mass fits for double-tag RS (upper) and WS (lower) positron candidates with momentum in the range 450–500 MeV/ c from $E_{\text{cm}} = 4.178$ GeV data. In both plots, the solid blue line is the result of the total fit, the dashed red line is the fitted distribution of non- $D_s^- \rightarrow K^+ K^- \pi^-$ backgrounds, the dotted black line is the fitted signal distribution, the filled red histogram is the contribution from backgrounds predicted by MC simulation, and the black points with error bars are data. The choice of binning is arbitrary and used solely for display. MC simulation distributions are scaled by the number of single-tag events.

parameters fixed to those determined in the single-tag fit. We employ a first-order Chebyshev polynomial to model the distribution of backgrounds. Two examples of the 324 fits we perform are shown in Fig. 3. The full set of fits is made available as Supplemental Material [36].

TABLE IV. Single-tag efficiencies for all events (ϵ_{ST}) and tag bias for $D_s^+ \rightarrow X e^+ \nu_e$ events (b_{tag}) and for $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events (b_{tag}^τ) from each dataset determined with MC samples. Listed uncertainties are only statistical.

Dataset	ϵ_{ST}	b_{tag}	b_{tag}^τ
$E_{\text{cm}} = 4.178$ GeV	$(43.10 \pm 0.01)\%$	1.007 ± 0.001	1.037 ± 0.003
$E_{\text{cm}} = 4.189\text{--}4.219$ GeV	$(42.46 \pm 0.02)\%$	1.004 ± 0.002	1.034 ± 0.004
$E_{\text{cm}} = 4.225\text{--}4.230$ GeV	$(40.48 \pm 0.03)\%$	1.005 ± 0.003	1.044 ± 0.007

Measured yields as a function of momentum bin for each category are shown in Fig. 4.

With the yields determined from the fits, we perform the matrix unfolding procedure described in Sec. III to correct for the inefficiencies of our electron/positron identification and for the misidentification of pions and kaons as electrons in each momentum bin for both RS and WS tracks, as described in Eq. (3). The elements of A_{PID} for each dataset are determined by applying our PID requirements to MC samples of particles originating from D_s^+ decays. Differing detector conditions of the three datasets introduce deviations among the PID rates from

the datasets. The rates that populate the A_{PID} matrices are shown in Fig. 5 for each dataset. The results of the unfolding procedure for both RS and WS tracks are shown in Fig. 6, as well as the difference of the PID-unfolded right-sign and wrong-sign yields, which gives the PID-unfolded momentum spectra for tracked positrons originating from $D_s^+ \rightarrow X e^+ \nu_e$ and $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events. The assessment of systematic uncertainties related to the two rates to which we are most sensitive (the electron identification efficiency and the pion-to-electron misidentification rate) are discussed in Sec. VI.

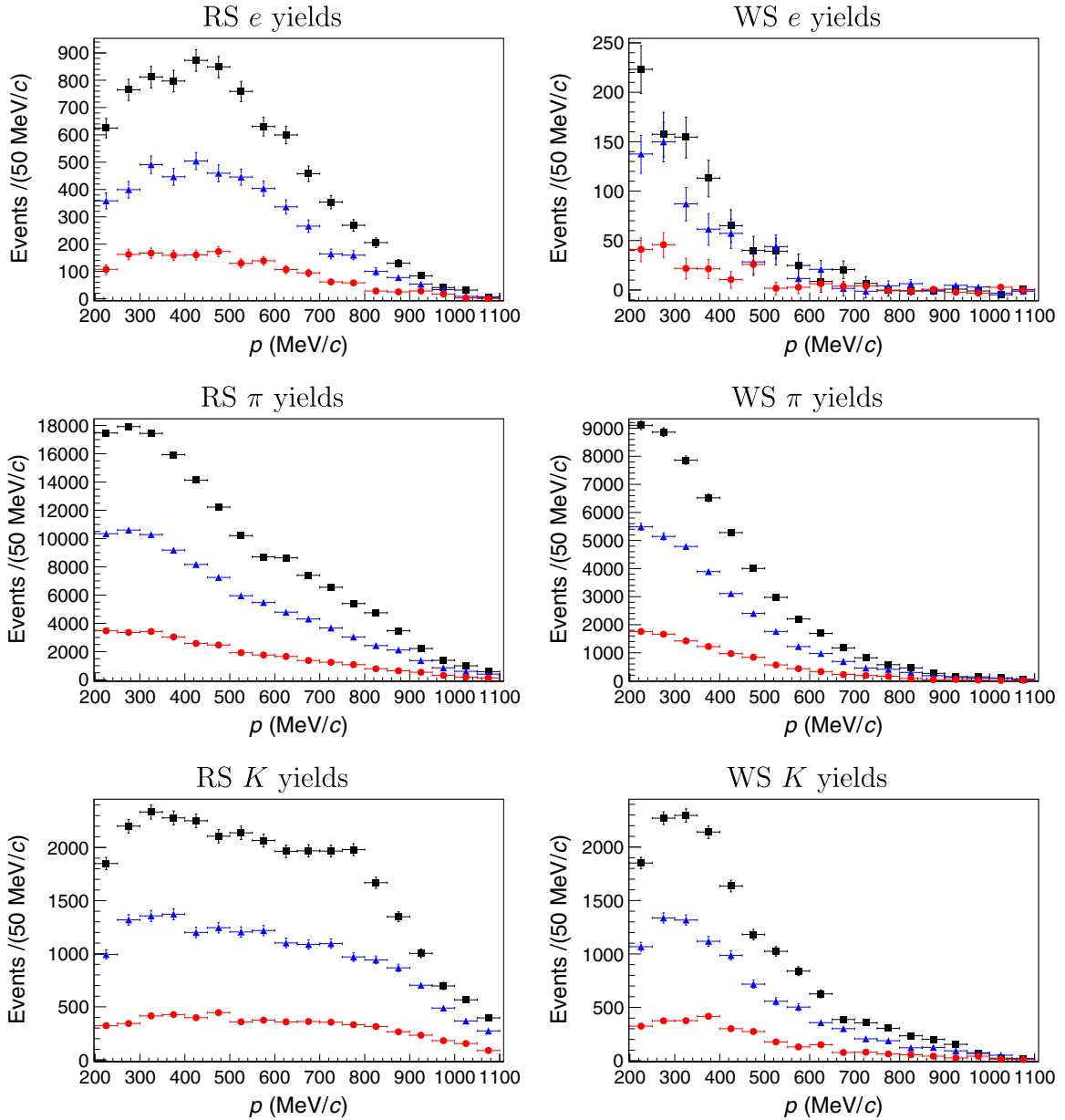


FIG. 4. Measured yields for each track category as a function of momentum. The results from $E_{\text{cm}} = 4.178$ GeV are shown as black squares, those from $E_{\text{cm}} = 4.189\text{--}4.219$ GeV are shown as blue triangles, and those from $E_{\text{cm}} = 4.225\text{--}4.230$ GeV are shown as red circles.

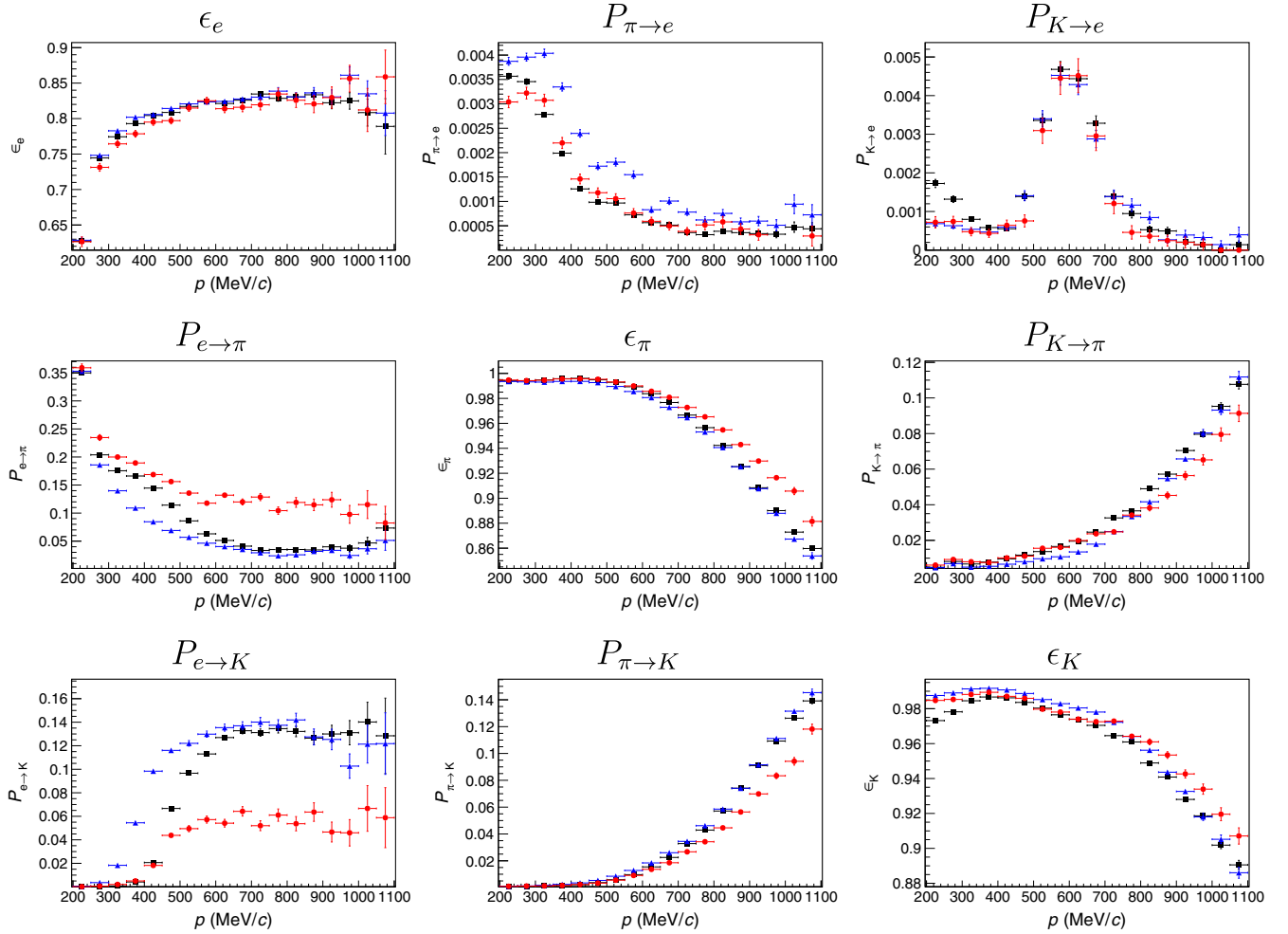


FIG. 5. PID rates as a function of momentum used to populate the A_{PID} matrices. Entries from $E_{\text{cm}} = 4.178$ GeV are shown as black squares, those from $E_{\text{cm}} = 4.189\text{--}4.219$ GeV are shown as blue triangles, and those from $E_{\text{cm}} = 4.225\text{--}4.230$ GeV are shown as red circles.

After taking the difference of the RS and WS PID-corrected yields, we apply the tracking unfolding matrix to correct for tracking reconstruction efficiencies and momentum bin misassignment as in Eq. (4). The momentum bin misassignment is caused not only by imperfect detector resolution but also by FSR from electrons and positrons, which increases the likelihood for the track momentum to be less than the momentum produced in the D_s^+ decay. The tracking unfolding matrices are consistent among the MC samples.

We determine the $D_s^+ \rightarrow X e^+ \nu_e$ positron momentum spectrum for each data sample by subtracting the contribution of positrons from $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events from the spectra obtained from the tracking unfolding procedure. We take the $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ positron momentum spectra from MC samples. We fix the normalization according to

$$N_{\text{DT},\tau} = \mathcal{B}(D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau) \times n_{\text{ST}} \times b_{\text{tag}}^\tau, \quad (8)$$

where the values of $\mathcal{B}(D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau)$ and b_{tag}^τ are given in Tables I and IV, respectively. The subtracted τ component is shown for each dataset in Fig. 7.

By determining the signal-efficiency-corrected number of $D_s^+ \rightarrow X e^+ \nu_e$ events in each dataset with $p_e > 200$ MeV/c, all effects of the detector response, except for small effects in b_{tag}^τ , have been accounted for. As such, we sum the determined yields from each dataset in each momentum bin to produce a combined $D_s^+ \rightarrow X e^+ \nu_e$ momentum spectrum. A table with the total summed yields as a function of momentum along with their statistical uncertainties is provided in the Supplemental Material [36]. We determine the number of $D_s^+ \rightarrow X e^+ \nu_e$ events with $p_e \leq 200$ MeV/c by fitting a shape based on MC simulation to the combined yields with $p_e > 200$ MeV/c. The shape is constructed by adding the momentum spectra predicted by MC simulation of the six observed exclusive modes ($\phi e^+ \nu_e, \eta e^+ \nu_e, \eta' e^+ \nu_e, K^0 e^+ \nu_e, K^*(892)^0 e^+ \nu_e$, and $f_0(980) e^+ \nu_e$) in proportion to their branching fractions

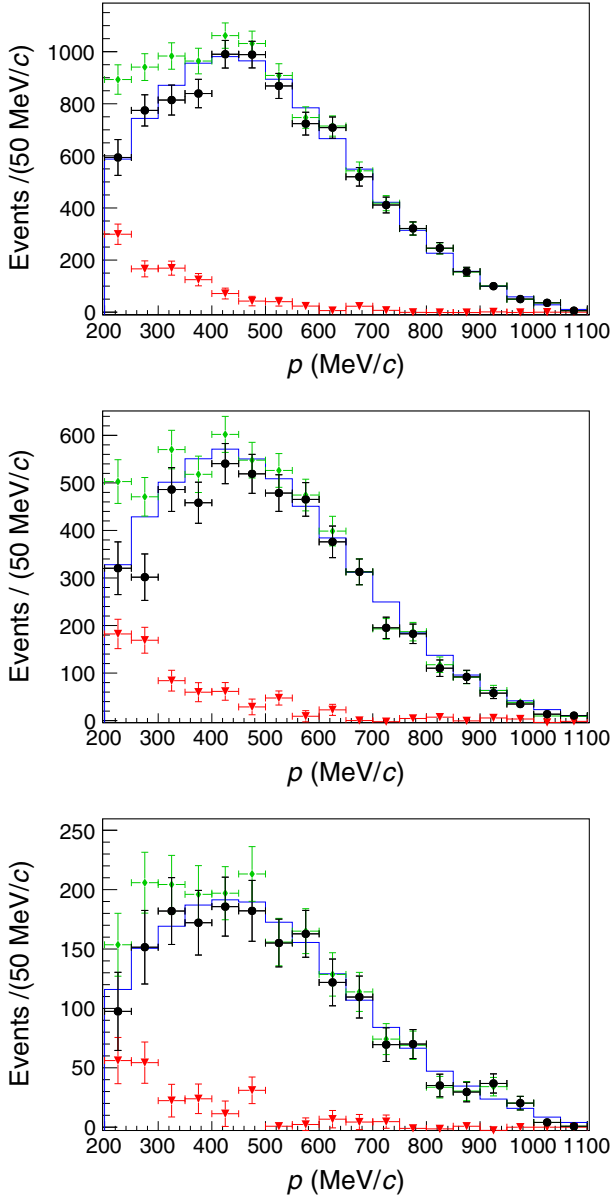


FIG. 6. PID unfolding results of positrons from $D_s^+ \rightarrow X e^+ \nu_e$ and $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events for the datasets with $E_{\text{cm}} = 4.178$ GeV (upper), $E_{\text{cm}} = 4.189\text{--}4.219$ GeV (middle), and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV (lower). RS PID-corrected yields are shown as green diamonds, WS PID-corrected yields are shown as red triangles, their differences are shown as black circles, and the predictions from MC samples scaled by the number of single-tag events are shown as blue histograms.

listed in Table I. The momentum spectra for the $\eta^+ e^+ \nu_e$, $K^0 e^+ \nu_e$, $K^*(892)^0 e^+ \nu_e$, and $f_0(980) e^+ \nu_e$ modes are taken from MC samples generated with the ISGW2 model [37] for the decay of the D_s^+ meson. We generate separate MC samples for the two largest modes, $\phi e^+ \nu_e$ and $\eta e^+ \nu_e$, using simple-pole parametrizations of the respective decay form factors as functions of the 4-momentum squared of the lepton-neutrino system (q^2). The form-factor parameters

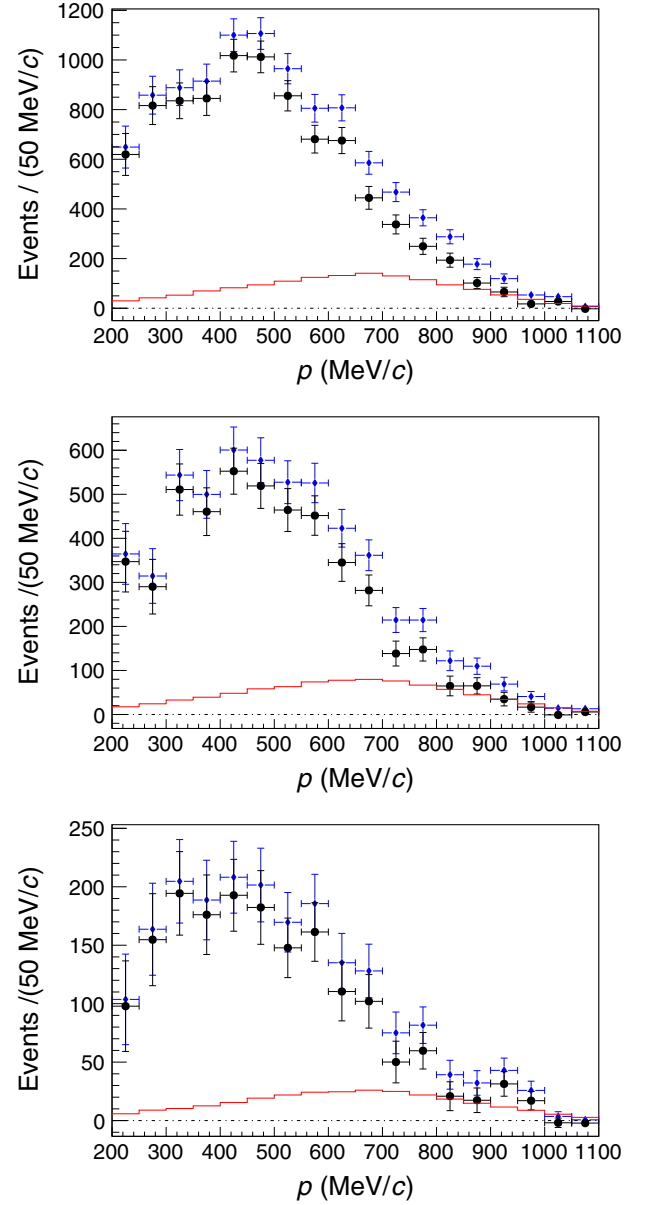


FIG. 7. Results of subtracting the contribution of $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \bar{\nu}_\tau \nu_\tau$ in $E_{\text{cm}} = 4.178$ GeV data (upper), $E_{\text{cm}} = 4.189\text{--}4.219$ GeV data (middle), and $E_{\text{cm}} = 4.225\text{--}4.230$ GeV data (lower). Tracking-corrected yields are shown as blue diamonds, and the predicted contributions from $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ are shown as red histograms. The differences of the two, the $D_s^+ \rightarrow X e^+ \nu_e$ yields, are shown as black circles. The dotted black line indicates zero events.

are taken from measurements of the *BABAR* Collaboration for $\phi e^+ \nu_e$ [3] and the *BESIII* Collaboration for $\eta e^+ \nu_e$ [7].

The integral of the fitted spectrum from $p_e = 0$ MeV/ c to $p_e = 200$ MeV/ c is added to the number of signal-efficiency-corrected $D_s^+ \rightarrow X e^+ \nu_e$ events with $p_e > 200$ MeV/ c as described in Eq. (5), and the statistical uncertainty is scaled by the ratio by which the total yield increases due to this correction. The fit to data with the

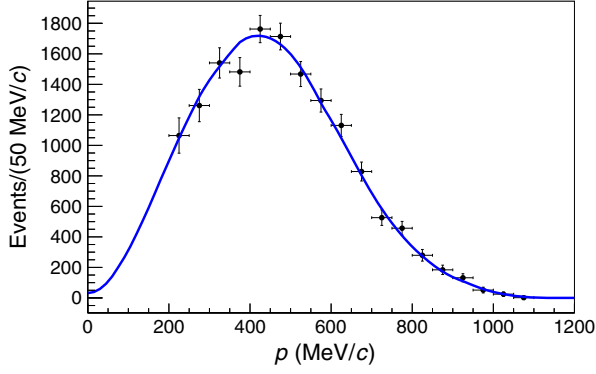


FIG. 8. Momentum spectrum fit used to determine the D_s^+ semielectronic decay yield below 200 MeV/c. The black points with error bars are sums of the final measured $D_s^+ \rightarrow Xe^+\nu_e$ yields (black circles) for the three datasets from Fig. 7, and the solid blue line is result of the fit described in the text.

assumed momentum spectrum can be found in Fig. 8. As a cross-check, we also fit to the datasets separately and find consistent results. The yields in data both without and with the correction for the data with $p_e < 200$ MeV/c are shown in Table V.

Using Eq. (6), we determine $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$ with the momentum-extrapolated number of signal-efficiency-corrected double-tag events from Table V, the observed number of single-tag events from Table III, and the tag bias from Table IV. The branching fractions determined from each dataset independently, their average, and the branching fraction determined from their combination are

TABLE V. Yields in data before and after momentum-extrapolation correction. The “Combined” row shows the results of summing together the yields from the three datasets and fitting to the summed distribution. Shown uncertainties are only statistical.

Sample	Observed yields with $p_e > 200$ MeV/c	Corrected yields (N_{DT})
$E_{cm} = 4.178$ GeV	8793 ± 218	9628 ± 238
$E_{cm} = 4.189\text{--}4.219$ GeV	4695 ± 174	5142 ± 191
$E_{cm} = 4.225\text{--}4.230$ GeV	1712 ± 104	1874 ± 114
Combined	15201 ± 298	16648 ± 326

TABLE VI. $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$ determined from data. The “Combined” row shows the results of summing together the yields from the three datasets and fitting to the summed distribution. Shown uncertainties are only statistical.

Sample	$\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$
$E_{cm} = 4.178$ GeV	$(6.38 \pm 0.16)\%$
$E_{cm} = 4.189\text{--}4.219$ GeV	$(5.96 \pm 0.23)\%$
$E_{cm} = 4.225\text{--}4.230$ GeV	$(6.38 \pm 0.40)\%$
Combined	$(6.30 \pm 0.13)\%$

TABLE VII. Systematic uncertainties in the measurement of $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$.

Source	Relative uncertainty
Tracking	0.7%
PID	0.8%
Spectrum extrapolation	0.7%
Background shapes	0.4%
Number of tags	0.6%
Tag bias	0.1%
$\mathcal{B}(D_s^+ \rightarrow \tau^+\nu_\tau)$	0.6%
Overall	1.6%

shown along with the associated statistical uncertainties in Table VI. The difference of the “Combined” result from Table VI, $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e) = (6.30 \pm 0.13(\text{stat.}))\%$, and the sum of the observed exclusive semielectronic branching fractions from Table I gives the unobserved D_s^+ semielectronic branching fraction as $(-0.04 \pm 0.21)\%$, where the stated uncertainty includes the total uncertainty from the exclusive measurements, but only the statistical uncertainty from the inclusive measurement presented in this article.

VI. SYSTEMATIC UNCERTAINTY

Our methods to determine the relative systematic uncertainty in our measured $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$ are described below.

A. MC simulation statistics and matrix-inversion stability

We probe the effects of finite MC sample statistics and the stability of the matrix-inversion algorithm by creating a toy ensemble of variations for each efficiency matrix used in the analysis (54 PID and three tracking matrices). For each matrix, we create this ensemble by sampling each entry within the MC sample’s statistical uncertainty. For each matrix in each ensemble, we perform the matrix inversion and reperform the analysis with the new inverted matrix. All variations produce a negligible change in our final result, which indicates a negligible systematic uncertainty from the statistical uncertainty of the MC samples as well as the stability of the algorithm for inverting our efficiency matrices.

B. Tracking

Simulation of our tracking efficiency is studied with a control sample of radiative Bhabha events. Tracking efficiencies as a function of momentum are measured in each dataset as well as in MC samples produced with the BABAYAGANLO package [28]. The ratios of the measured efficiencies in data and MC samples are weighted by the predicted momentum distribution from signal MC simulation and the number of single-tag events in each dataset to

determine the systematic uncertainty. This results in a relative systematic uncertainty of 0.7%.

In addition, we investigate the systematic uncertainty in the individual tracking efficiency matrix entries. As we assign a systematic uncertainty for the total tracking efficiency, we probe the uncertainty in the individual entries by keeping the sum of a row of the matrix constant while varying the individual entries. The specific variation is as follows:

- (i) $(A_{\text{trk}})_{i,i-1} \Rightarrow 1.5(A_{\text{trk}})_{i,i-1}$
- (ii) $(A_{\text{trk}})_{i,i+1} \Rightarrow 1.25(A_{\text{trk}})_{i,i+1}$
- (iii) $(A_{\text{trk}})_{i,i}$ decreases to keep the sum of the column constant.

This variation is chosen as a conservative estimation of the uncertainties from FSR and detector resolution. We see negligible change when we perform such a variation, so we only assign the previously stated uncertainty for tracking.

C. PID

Similar to our procedure in assessing the systematic uncertainty in our tracking efficiencies, we measure e ID efficiencies as a function of momentum and track angle in radiative Bhabha control samples for each dataset.

We also probe the accuracy of the pion-to-electron misidentification rates from MC simulation via a control sample of pions collected in each data sample through the decay chains $D^{*+} \rightarrow \pi^+ D^0$, $D^0 \rightarrow K^- \pi^+$, $K^- \pi^+ \pi^+ \pi^-$. To determine the total uncertainty from PID rates, we simultaneously vary the e ID efficiencies and the pion-to-electron misidentification rates using the central values of the measured data-to-MC efficiency ratios and reperform our analysis. This yields a 0.8% change in the final branching fraction, which we assign as the relative systematic uncertainty due to PID.

As our sensitivity to kaon-to-electron misidentification rates is small due to the relatively few number of kaons, the systematic uncertainty in kaon-to-electron misidentification rates is neglected.

D. Tag bias

We follow the procedure laid out in Ref. [38], which assigns a fraction of $1 - b_{\text{tag}}$ as the systematic uncertainty based on the particles in the final state of the single-tag D_s^- decay. The specific guidelines for variation of detector-response parameters are as follows: 1.0% per kaon for tracking, 0.5% per pion for tracking, and 0.5% per kaon or pion for PID. For $D_s^- \rightarrow K^+ K^- \pi^-$, with two kaons and one pion, the quadrature sum is 2.9%. With b_{tag} from Table IV (including the contribution from $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$), taking 2.9% of $1 - b_{\text{tag}}$ yields a 0.03% relative systematic uncertainty. We additionally propagate the uncertainties in the branching fractions (Table I) through the calculation of the weighted-average b_{tag} . This yields a 0.07% relative systematic uncertainty in the bias. We add these in

quadrature and assign the relative systematic uncertainty due to tag bias as 0.1%.

E. Number of single tags

We investigate the systematic uncertainty in the invariant-mass fitting procedure used to determine the number of single tags by varying the choice of background distribution from the nominal second-order Chebyshev polynomial. We use both first-order and third-order Chebyshev polynomials as variations in fitting to each dataset. Using the first-order Chebyshev polynomial gives a larger difference in the yields in all cases, while not significantly degrading the quality of the fit. We take an average of the changes for each dataset weighted by the single-tag yields to determine the systematic uncertainty, which results in a 0.6% relative systematic uncertainty in the number of single tags.

F. Background shapes

To assess the uncertainty due to our chosen background shapes in our signal-side fits of the tag invariant mass, we use smoothed background distributions from MC simulation instead of the nominal first-order Chebyshev polynomial to model backgrounds in each of the signal-side fits. We then reperform the analysis with the yields determined from these alternative fits. The relative difference in N_{DT} is 0.4%, which we assign as the relative systematic uncertainty due to this source.

G. $\mathcal{B}(D_s^+ \rightarrow \tau^+ \nu_\tau)$

As systematic uncertainty in the kinematic distributions of $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events contributes negligible uncertainty, we account for uncertainty in the contribution of $D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau$ events by propagating the absolute uncertainty for $\mathcal{B}(D_s^+ \rightarrow \tau^+ \nu_\tau \rightarrow e^+ \nu_e \nu_\tau \bar{\nu}_\tau)$ from Table I, 0.04%. This yields a relative systematic uncertainty of 0.6% on our measurement of $\mathcal{B}(D_s^+ \rightarrow X e^+ \nu_e)$.

H. Spectrum extrapolation

We assess the uncertainty due to the momentum spectrum extrapolation by generating an ensemble of alternative momentum spectra and fitting these to the data. Each spectrum in this ensemble is created by Gaussian sampling the branching fractions of the six observed exclusive semielectronic modes and adding spectra for unobserved decay modes. We then add these spectra in proportion based on the sampled branching fractions.

We consider effects from the combination of three unobserved decay modes: $D_s^+ \rightarrow h_1(1415)e^+ \nu_e$, $D_s^+ \rightarrow f_1(1510)e^+ \nu_e$, and $D_s^+ \rightarrow \gamma e^+ \nu_e$. MC samples for $D_s^+ \rightarrow h_1(1415)e^+ \nu_e$ and $D_s^+ \rightarrow f_1(1510)e^+ \nu_e$ are generated based on the ISGW2 model's predictions [37]. We generate MC samples for $D_s^+ \rightarrow \gamma e^+ \nu_e$ based on the model of Yang and Yang [39]. We determine the normalization of the

$D_s^+ \rightarrow h_1(1415)e^+\nu_e$ and $D_s^+ \rightarrow f_1(1510)e^+\nu_e$ spectra by fixing the relative branching fraction of these decays to the ISGW2 predictions and fitting them in addition to our nominal momentum spectrum. The $D_s^+ \rightarrow \gamma e^+\nu_e$ spectrum is fixed to its measured 90% confidence-level upper limit, 1.3×10^{-4} [40]. From this fit, we determine an upper limit at the 90% confidence level for the sum of the branching fractions of $D_s^+ \rightarrow h_1(1415)e^+\nu_e$ and $D_s^+ \rightarrow f_1(1510)e^+\nu_e$. In our toy ensemble, their summed spectra are fixed based on this upper limit. We performed this same procedure excluding the $D_s^+ \rightarrow \gamma e^+\nu_e$ spectrum but found the combination of modes to produce the largest variation.

The resulting systematic uncertainty is determined by filling a distribution of the relative change in $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$ between the alternative momentum spectra and our nominal spectrum. The linear sum of the mean (0.33%) and rms (0.34%) of this distribution is taken as the uncertainty, which gives a 0.7% relative systematic uncertainty.

We also probe uncertainty in the models we employ by using the ISGW2-predicted momentum spectra for the $D_s^+ \rightarrow \phi e^+\nu_e$ and $D_s^+ \rightarrow \eta e^+\nu_e$ modes. Using these alternative spectra instead of the nominal spectra gives a less than 0.1% difference in the measured branching fraction, so we conclude that any uncertainty due to model dependence in our analysis is negligible.

I. Summary of systematic uncertainties

The assigned relative systematic uncertainties for all sources are listed in Table VII. Our systematic uncertainty is not dominated by any single source, but the largest contributions come from the momentum spectrum extrapolation and imperfect simulation of PID and tracking efficiencies. The total relative systematic uncertainty is obtained from the quadrature sum of the assigned relative uncertainties. This gives a total relative systematic uncertainty of 1.6%.

VII. CONCLUSIONS

Using data collected by the BESIII detector in the center-of-mass-energy range of $E_{\text{cm}} = 4.178\text{--}4.230$ GeV, we measure the inclusive semielectronic branching fraction of the D_s^+ meson to be

$$\begin{aligned} \mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e) \\ = (6.30 \pm 0.13(\text{stat.}) \pm 0.09(\text{syst.}) \pm 0.04(\text{ext.}))\%, \end{aligned}$$

where the external systematic uncertainty is from $\mathcal{B}(D_s^+ \rightarrow \tau^+\nu_\tau)$. We also measure the laboratory-frame momentum spectrum of the positrons produced in this decay, which can be seen in Fig. 8.

Our result is consistent with the measurement from the CLEO-c experiment [1],

$$\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e) = (6.52 \pm 0.39(\text{stat.}) \pm 0.15(\text{syst.}))\%,$$

with a factor of 3 reduction of the statistical uncertainty and a factor of 1.5 reduction of the systematic uncertainty, primarily due to increased precision on external inputs. The total precision of our measurement is 2.6%, which corresponds to approximately a 2.5 times improvement in the total precision compared to the measurement from CLEO-c.

By taking the difference between our measurement of $\mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e)$ and the sum of the best available measurements for the exclusive semielectronic modes in Table I, we calculate the unobserved semielectronic branching fraction to be

$$\begin{aligned} \mathcal{B}(D_s^+ \rightarrow Xe^+\nu_e) - \sum_i \mathcal{B}(D_s^+ \rightarrow X_i e^+\nu_e) \\ = (-0.04 \pm 0.13(\text{stat.}) \pm 0.09(\text{syst.}) \pm 0.17(\text{ext.}))\%, \end{aligned}$$

where the external systematic uncertainty includes the total uncertainty in the measured exclusive branching fractions and the uncertainty in $\mathcal{B}(D_s^+ \rightarrow \tau^+\nu_\tau)$. Our measurement provides no evidence for the existence of unobserved D_s^+ semileptonic decay modes and constrains the branching fractions of all unobserved decay modes. In addition, the measured momentum spectrum can be used to further constrain the decay rates of modes with characteristic momentum spectra. The spectrum is included in tabular form in the Supplemental Material [36].

With our updated measurement of the D_s^+ semielectronic branching fraction, the CLEO-c measurement of the D^0 semielectronic branching fraction [1], and the 2020 PDG values for the D_s^+ and D^0 lifetimes [35], we find

$$\begin{aligned} \frac{\Gamma(D_s^+ \rightarrow Xe^+\nu_e)}{\Gamma(D^0 \rightarrow Xe^+\nu_e)} \\ = 0.790 \pm 0.016(\text{stat.}) \pm 0.011(\text{syst.}) \pm 0.016(\text{ext.}). \end{aligned}$$

where the external systematic uncertainty includes the total uncertainty from $\mathcal{B}(D^0 \rightarrow Xe^+\nu_e)$, the D^0 and D_s^+ lifetimes, and $\mathcal{B}(D_s^+ \rightarrow \tau^+\nu_\tau)$. This result is in agreement with the prediction of $\frac{\Gamma(D_s^+ \rightarrow Xe^+\nu)}{\Gamma(D^0 \rightarrow Xe^+\nu)} = 0.813$ from Ref. [18], supporting the conclusion that the difference in the semileptonic decay widths of D_s^+ and D^0 mesons can be accounted for within the Standard Model by nonspectator interactions. Further theoretical analysis of our measured spectrum, similar to those of Refs. [19,20], can constrain specific processes like weak annihilation of the constituent c and \bar{s} quarks of the D_s^+ meson, with potential extensions to determinations of $|V_{ub}|$ in semileptonic B decays [21].

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